



DESCRIPTION

The AM40T120B is available in TO-247 Package

VCES	IC	VCE	PD
1200V	40A	2.0V	357W

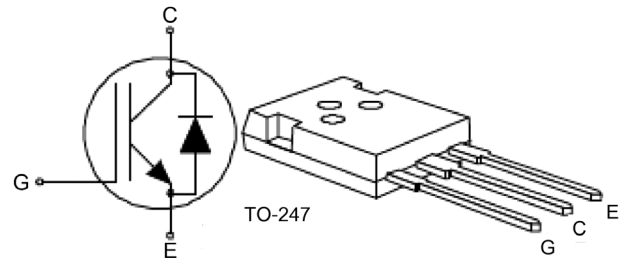
FEATURES

- Fast Switching
- Low $V_{CE(sat)}$: 2.0V
- Positive Temperature Coefficient
- Very Soft, Fast Recovery Anti-Parallel Diode
- Irrm: 14.9A

APPLICATION

- UPS
- Welding Converters
- Converters With High Switching Frequency

PIN DESCRIPTION



ORDERING INFORMATION

Package Type	Part Number	
TO-247 SPQ:30pcs/Tube	TL3F	AM40T120ATL3FU
		AM40T120ATL3FVU
Note	V: Halogen free Package U: Tube	
AiT provides all RoHS products		

Pin#	Symbol	Function
1	G	Gate
2	C	Collector
3	E	Emitter



ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Units
Collector-Emitter Voltage	V _{CES}	1200	V
Collector Current @ T _c = 25 °C	I _c	80	A
Collector Current @ T _c = 100 °C		40	A
Pulsed Collector Current ⁽¹⁾ @ T _c = 25 °C	I _{CM}	160	A
Diode Continuous Forward Current @ T _c = 25 °C	I _F	40	A
Diode Continuous Forward Current @ T _c = 100 °C		20	A
Diode Maximum Forward Current @ T _c = 25 °C	I _{FM}	160	A
Gate-Emitter Voltage	V _{GES}	±20	V
Power Dissipation @ T _c = 25 °C	P _D	357	W
Storage Temperature Range	T _{stg}	-55 to 150	°C
Junction Temperature	T _J	150	°C
Maximum Temperature for Soldering	T _L	260	°C
THERMAL CHARACTERISTICS			
Junction-to-Case (IGBT)	R _{θJC}	0.34	°C/W
Junction-to-Case (Diode)	R _{θJC}	0.8	°C/W
Junction-to-Ambient	R _{θJA}	40	°C/W

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

(1) Pulse width limited by maximum junction temperature



ELECTRICAL CHARACTERISTICS

T_A=25°C, unless otherwise specified.

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Units
OFF CHARACTERISTICS						
Collector-Emitter Breakdown Voltage	V _{CE(S)}	V _{GE} =0V, I _C =250μA	1200	-	-	V
Collector-Emitter Leakage Current	I _{CE(S)}	V _{CE} = 1200V, V _{GE} = 0V	-	-	250	μA
Gate-Emitter Leakage Current	I _{GES(F)}	V _{GE} = +20V	-	-	600	nA
Gate-Emitter Reverse Leakage	I _{GES(R)}	V _{GE} = -20V	-	-	-600	nA
ON CHARACTERISTICS						
Collector-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} = 15V, I _C =40A	-	2.0	2.4	V
Gate Threshold Voltage	V _{GE(TH)}	V _{CE} = V _{GE} , I _C = 1mA	5.5	5.8	6.5	V
Pulse width t _p ≤300μs, δ≤2%						
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{iss}	V _{GE} = 0V	-	3633	-	pF
Output Capacitance	C _{oss}	V _{CE} = 25V	-	150	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0MHz	-	90	-	
Total Gate Charge	Q _g	I _C = 40A V _{CE} = 960V V _{GE} = 15V	-	270	-	nC
SWITCHING CHARACTERISTICS						
Turn-on Delay Time	t _{d(ON)}	I _C =40A	-	48	-	ns
Rise Time	t _r	V _{CE} = 600V	-	90	-	
Turn-Off Delay Time	t _{d(OFF)}	V _{GE} = 15V	-	275	-	
Fall Time	t _f	R _G =10Ω	-	55	-	
Turn-On Switching Loss	E _{on}	Inductive Load	-	4.694	-	mJ
Turn-Off Switching Loss	E _{off}		-	1.627	-	
Total Switching Loss	E _{ts}		-	6.321	-	
DIODE CHARACTERISTICS						
Diode Forward Voltage	V _F	I _F =40A	-	2	2.5	V
Reverse Recovery Time	T _{rr}	I _F =40A, di/dt=200A/us	-	73	-	nS
Reverse Recovery Charge	Q _{rr}		-	654	-	nC
Reverse Recovery Current	I _{rrm}		-	14.9	-	A



TYPICAL PERFORMANCE CHARACTERISTICS

Fig.1 Forward Bias Safe Operating Area

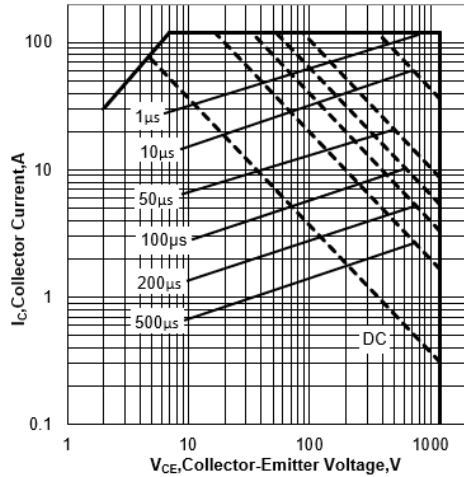


Fig.2 Power Dissipation vs Case Temperature

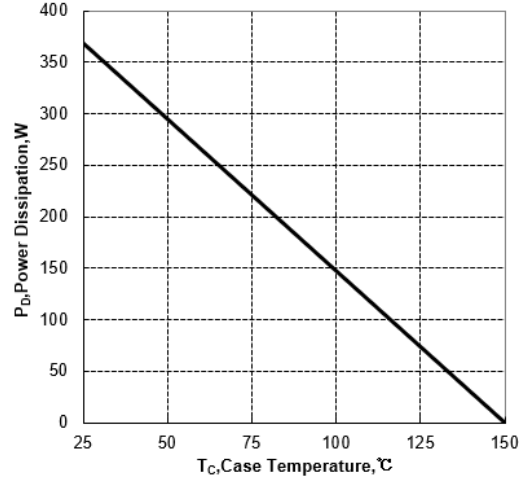


Fig.3 Collector Current vs Case Temperature

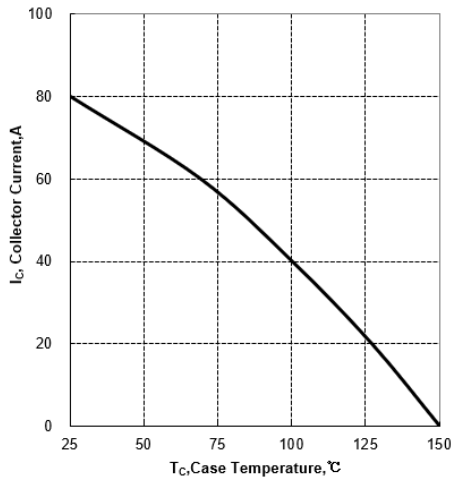


Fig.4 Typical Transfer Characteristics

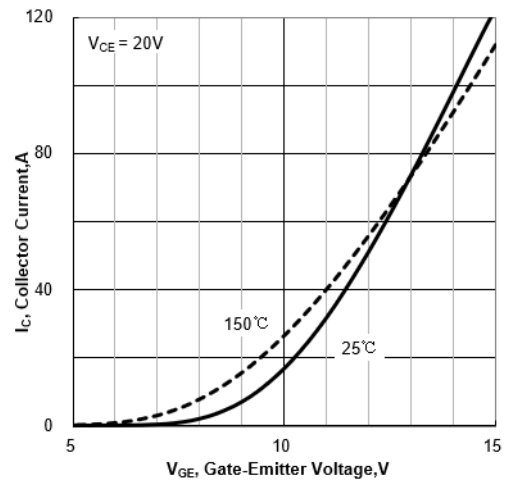


Fig.5 Typical Output Characteristics ($T_C = 25^{\circ}$ C)

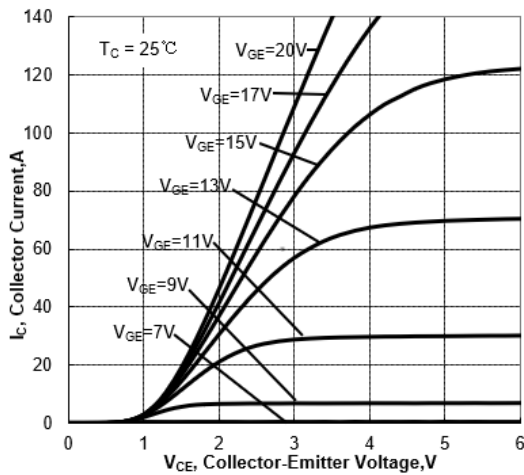


Fig.6 Typical Output Characteristics ($T_C = 150^{\circ}$ C)

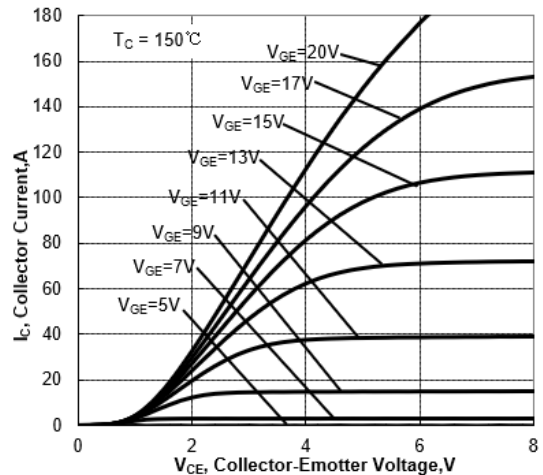




Fig.7 Typical Collector-Emitter Saturation Voltage vs Junction Temperature

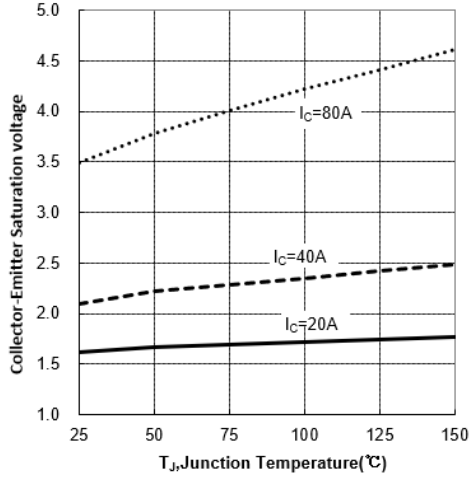


Fig.8 Typical Transfer Characteristics

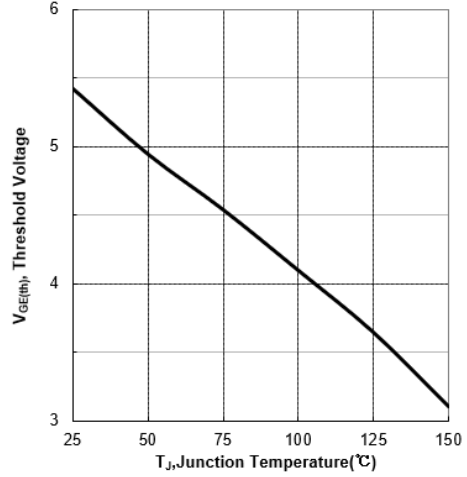


Fig.9 Typical Gate Charge

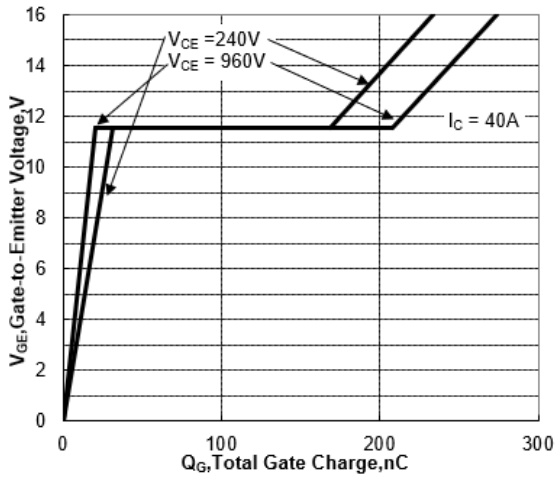


Fig.10 Typical Capacitance vs Collector-Emirrer Voltage

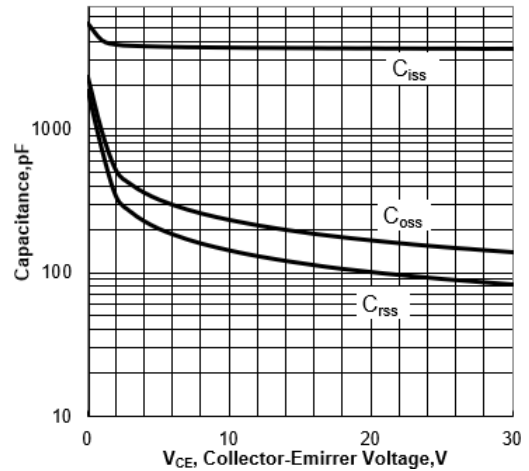


Fig.11 IGBT Transient Thermal Impedance vs Pulse Width

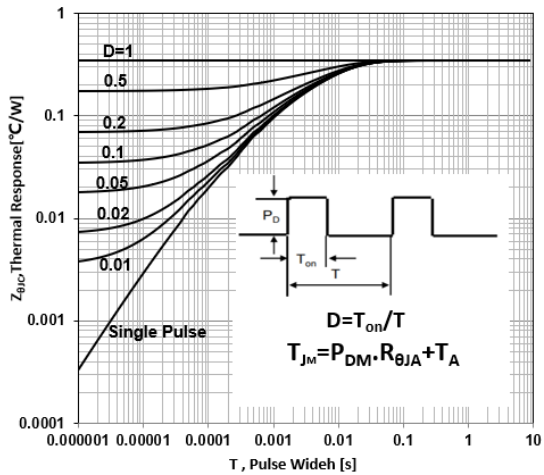


Fig.12 Diode Transient Thermal Impedance vs Pulse Width

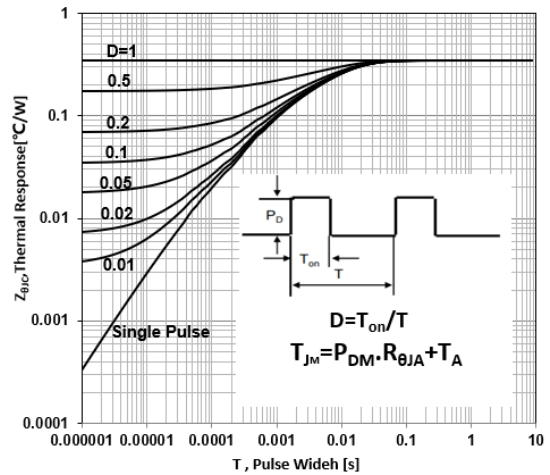




Fig.13 Typical Diode Forward Current vs Forward Voltage

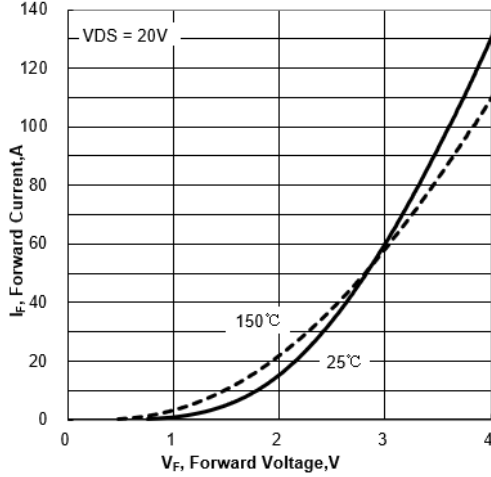


Fig.14 Inductive Switching Test Circuit

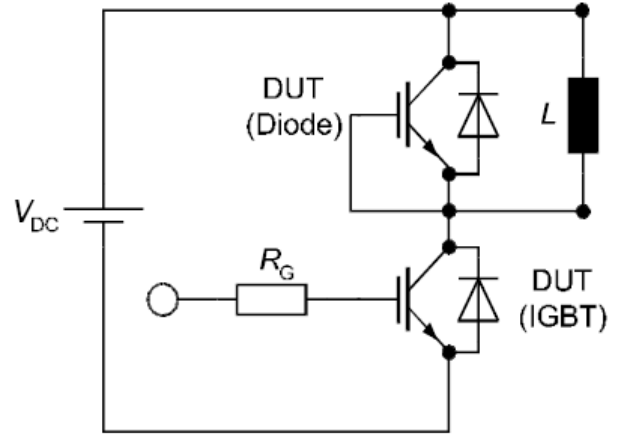


Fig.15 Inductive Switching Waveforms

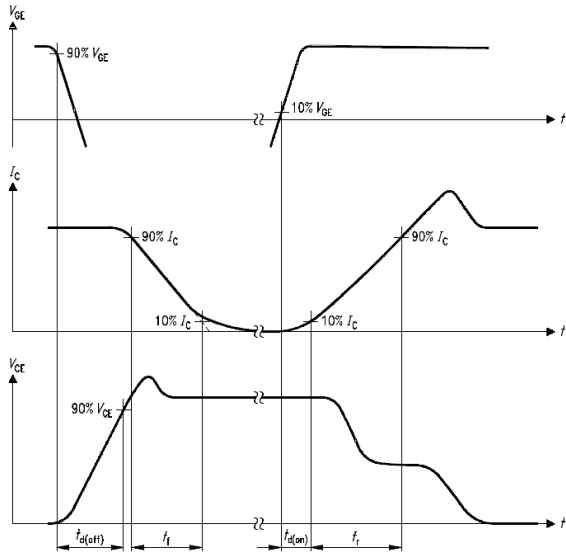


Fig.16. Inductive Switching Waveforms

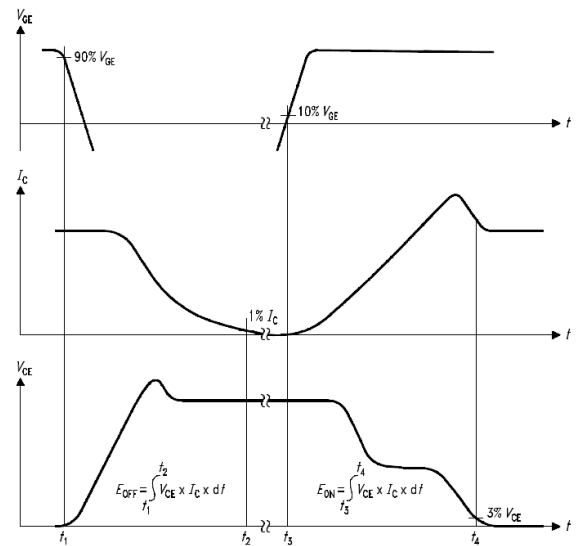
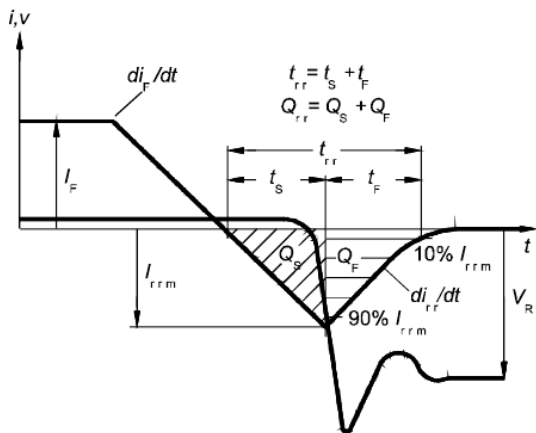


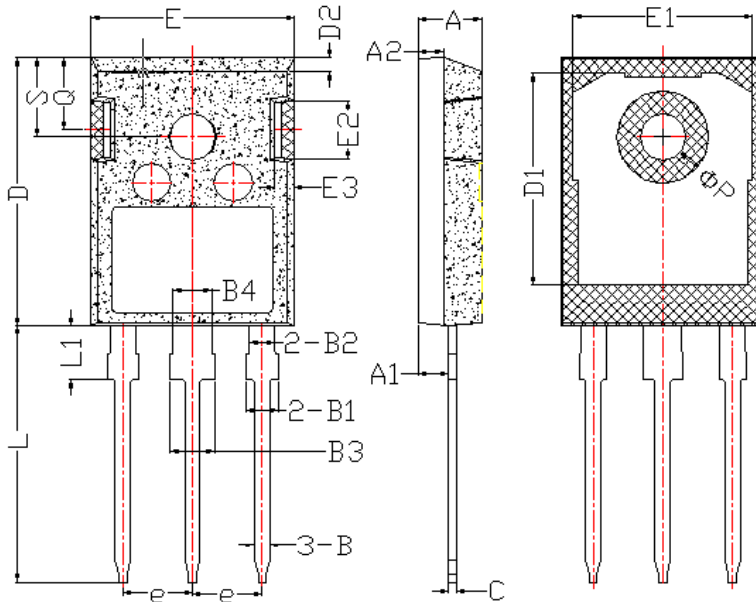
Fig.17. Inductive Switching Waveforms





PACKAGE INFORMATION

Dimension in TO-247 (Unit: mm)



Symbol	Min.	Max.	Symbol	Min.	Max.
A	4.900	5.160	D2	1.050	1.350
A1	2.270	2.530	E	15.700	16.030
A2	1.850	2.110	E1	13.100	14.150
B	1.070	1.330	E2	3.680	5.100
B1	1.900	2.410	E3	1.680	2.600
B2	1.750	2.150	e	5.440	
B3	2.870	3.380	L	19.800	20.310
B4	2.870	3.130	L1	4.170	4.470
C	0.550	0.680	ΦP	3.500	3.700
D	20.820	21.100	Q	5.490	6.000
D1	16.250	17.650	S	6.040	6.300



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